

<b>Notice of References Cited</b>		Application/Control No. 10/034,428	Applicant(s)/Patent Under Reexamination OLITA ET AL.	
		Examiner Heather R. Long	Art Unit 2615	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,859,327	02-2005	Del Bianco et al.	359/630
	B	US-2003/0169491	09-2003	Bender et al.	359/356
	C	US-6,606,114	08-2003	Gordon et al.	348/64
	D	US-5,200,827	04-1993	Hanson et al.	348/216.1
	E	US-2002/0030163	03-2002	Zhang, Evan Y.W.	250/330
	F	US-6,476,391	11-2002	Zhang, Evan Y. W.	250/330
	G	US-5,089,914	02-1992	Prescott, John A.	359/815
	H	US-5,949,582	09-1999	Coombs, Christopher E.	359/630
	I	US-5,584,073	12-1996	Radzelovage et al.	2/6.3
	J	US-6,560,029	05-2003	Dobbie et al.	359/631
	K	US-6,255,650	07-2001	Warner et al.	250/330
	L	US-6,683,584	01-2004	Ronzani et al.	345/8
	M	US-2005/0035925	02-2005	Ostromek et al.	345/008

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 00/45211	08-2000	Great Britain	Prescott, et al.	A42B 3/04
	O	JP 2004-244745	09-2004	Japan	Miyano, et al.	A42B 3/04
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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